

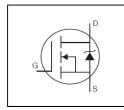
AUTOMOTIVE GRADE

AUIRF1010Z AUIRF1010ZS AUIRF1010ZL

HEXEET® POWER MOSEET

Features

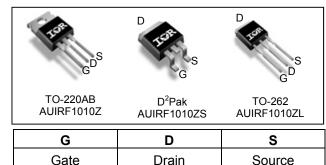
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Timax
- · Lead-Free, RoHS Compliant
- Automotive Qualified *



| | LEI FOMELMOSEET |
|----------------------------------|-----------------|
| V _{DSS} | 55V |
| R _{DS(on)} max. | 7.5mΩ |
| I _{D (Silicon Limited)} | 94A |
| D (Package Limited) | 75A |

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



| Bass nort number | Dook northweet Books Time | | k | Orderable Part Number |
|------------------|---------------------------|--------------------|----------|-----------------------|
| Base part number | Package Type | Form | Quantity | Orderable Part Number |
| AUIRF1010Z | TO-220 | Tube | 50 | AUIRF1010Z |
| AUIRF1010ZL | TO-262 | Tube | 50 | AUIRF1010ZL |
| AUIRF1010ZS | D²-Pak | Tube | 50 | AUIRF1010ZS |
| AUIRF 101025 | D -Pak | Tape and Reel Left | 800 | AUIRF1010ZSTRL |

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

| Symbol | Parameter | Max. | Units |
|---|---|-------------------------|-------|
| I _D @ T _C = 25°C | Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) | 94 | |
| I _D @ T _C = 100°C | Continuous Drain Current, V _{GS} @ 10V (Silicon Limited) | 66 | 1 |
| I _D @ T _C = 25°C | Continuous Drain Current, V _{GS} @ 10V (Package Limited) | 75 | A |
| I _{DM} | Pulsed Drain Current ① | 360 | 1 |
| P _D @T _C = 25°C | Maximum Power Dissipation | 140 | W |
| | Linear Derating Factor | 0.90 | W/°C |
| V _{GS} Gate-to-Source Voltage | | ± 20 | V |
| E _{AS} Single Pulse Avalanche Energy (Thermally Limited) ② | | 130 | ma I |
| E _{AS} (tested) | Single Pulse Avalanche Energy Tested Value ® | 180 | - mJ |
| I _{AR} | Avalanche Current ① | See Fig.15,16, 12a, 12b | Α |
| E _{AR} | Repetitive Avalanche Energy ® | | mJ |
| TJ | Operating Junction and | -55 to + 175 | |
| T_{STG} | Storage Temperature Range | | °C |
| | Soldering Temperature, for 10 seconds (1.6mm from case) | 300 | |
| _ | Mounting torque, 6-32 or M3 screw⑦ | 10 lbf•in (1.1N•m) | |

Thermal Resistance

| Symbol | Parameter | Тур. | Max. | Units |
|---------------------------------------|--|------|------|-------|
| R _{θJC} | Junction-to-Case 9 | | 1.11 | |
| Case-to-Sink, Flat, Greased Surface ⑦ | | 0.50 | | °CAM |
| R_{\thetaJA} | | | 62 | °C/W |
| $R_{	hetaJA}$ | Junction-to-Ambient (PCB Mount, steady state) ® | | 40 | |

HEXFET® is a registered trademark of Infineon.

^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

| | Parameter | Min. | Тур. | Max. | Units | Conditions |
|-----------------------------------|--------------------------------------|------|-------|------|-------|---|
| $V_{(BR)DSS}$ | Drain-to-Source Breakdown Voltage | 55 | | | V | $V_{GS} = 0V, I_{D} = 250\mu A$ |
| $\Delta V_{(BR)DSS}/\Delta T_{J}$ | Breakdown Voltage Temp. Coefficient | | 0.049 | | V/°C | Reference to 25°C, I _D = 1mA |
| R _{DS(on)} | Static Drain-to-Source On-Resistance | | 5.8 | 7.5 | mΩ | V _{GS} = 10V, I _D = 75A ③ |
| $V_{GS(th)}$ | Gate Threshold Voltage | 2.0 | | 4.0 | V | $V_{DS} = V_{GS}$, $I_D = 250\mu A$ |
| gfs | Forward Trans conductance | 33 | | | S | $V_{DS} = 25V, I_{D} = 75A$ |
| | Drain to Source Leakage Current | | | 20 | | $V_{DS} = 55 \text{ V}, V_{GS} = 0 \text{ V}$ |
| IDSS | Drain-to-Source Leakage Current | | | 250 | μA | $V_{DS} = 55V, V_{GS} = 0V, T_{J} = 125^{\circ}C$ |
| | Gate-to-Source Forward Leakage | | | 200 | - Λ | $V_{GS} = 20V$ |
| I _{GSS} | Gate-to-Source Reverse Leakage | | | -200 | nA | $V_{GS} = -20V$ |

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

| - | • | - | _ | | |
|------------------|------------------------------|----------|----|----|---|
| Q_g | Total Gate Charge | 63 | 95 | | I _D = 75A |
| Q_{gs} | Gate-to-Source Charge | 19 | | nC | $V_{DS} = 44V$ |
| Q_{gd} | Gate-to-Drain Charge | 24 | | | V _{GS} = 10V3 |
| $t_{d(on)}$ | Turn-On Delay Time | 18 | | | $V_{DD} = 28V$ |
| t _r | Rise Time | 150 | | | I _D = 75A |
| $t_{d(off)}$ | Turn-Off Delay Time | 36 | | ns | $R_G = 6.8\Omega$ |
| t _f | Fall Time | 92 | | | V _{GS} = 10V ③ |
| L_D | Internal Drain Inductance | 4.5 | | nH | Between lead, 6mm (0.25in.) |
| Ls | Internal Source Inductance | 7.5 | | Ш | from package and center of die contact |
| C _{iss} | Input Capacitance | 2840 | | | $V_{GS} = 0V$ |
| Coss | Output Capacitance | 420 | | | V _{DS} = 25V |
| C _{rss} | Reverse Transfer Capacitance | 250 | | "F | f = 1.0MHz, See Fig. 5 |
| C _{oss} | Output Capacitance | 1630 | | pF | $V_{GS} = 0V, V_{DS} = 1.0V f = 1.0MHz$ |
| Coss | Output Capacitance | 360 | | | $V_{GS} = 0V$, $V_{DS} = 44V$ $f = 1.0MHz$ |
| Coss eff. | Effective Output Capacitance | 560 | | | $V_{GS} = 0V, V_{DS} = 0V \text{ to } 44V $ |
| | | | | | |

Diode Characteristics

| | Parameter | Min. | Тур. | Max. | Units | Conditions | |
|-----------------|---|-----------|--|------|-------|--|--|
| I _S | Continuous Source Current (Body Diode) | | | 75 | | MOSFET symbol showing the | |
| I _{SM} | Pulsed Source Current (Body Diode) ① | | | 360 | A | integral reverse p-n junction diode. | |
| V_{SD} | Diode Forward Voltage | | | 1.3 | V | $T_J = 25^{\circ}C, I_S = 75A, V_{GS} = 0V $ ③ | |
| t _{rr} | Reverse Recovery Time | | 22 | 33 | ns | $T_J = 25^{\circ}C$, $I_F = 75A$, $V_{DD} = 25V$ | |
| Q_{rr} | Reverse Recovery Charge | | 15 | 23 | nC | di/dt = 100A/µs ③ | |
| t _{on} | Forward Turn-On Time | Intrinsio | Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D) | | | | |

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Limited by T_{Jmax_i} starting $T_J = 25$ °C, L = 0.05mH, $R_G = 25\Omega$, $I_{AS} = 75$ A, $V_{GS} = 10$ V. Part not recommended for use above this value.
- \oplus C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- © Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- \odot This value determined from sample failure population, starting T_J = 25°C, L = 0.05mH, R_G = 25 Ω , I_{AS} = 75A, V_{GS} =10V.
- This is only applied to TO-220AB package.
- ® When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994



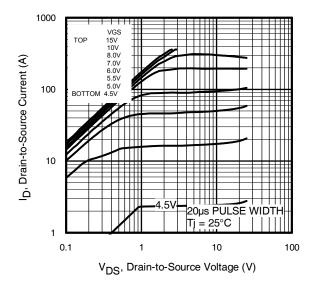


Fig. 1 Typical Output Characteristics

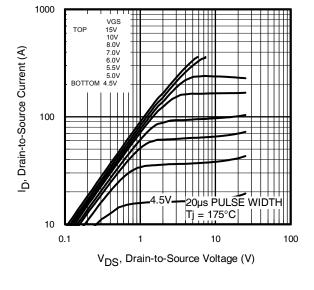


Fig. 2 Typical Output Characteristics

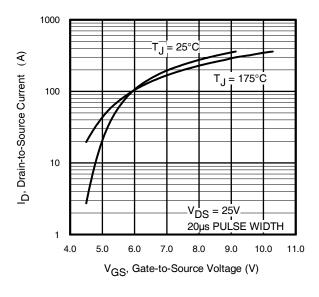


Fig. 3 Typical Transfer Characteristics

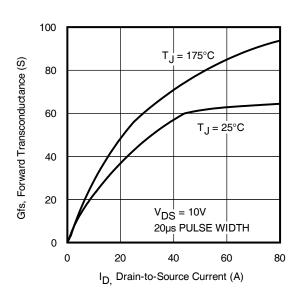


Fig. 4 Typical Forward Trans conductance vs. Drain Current



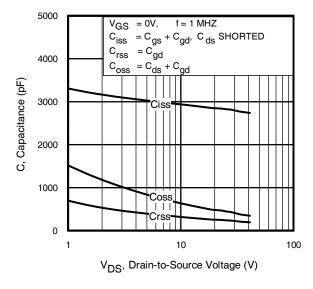


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

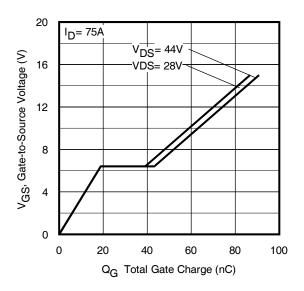


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

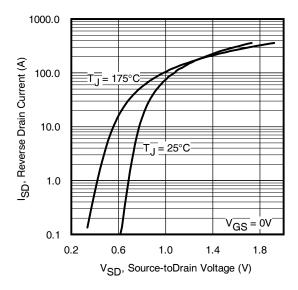


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

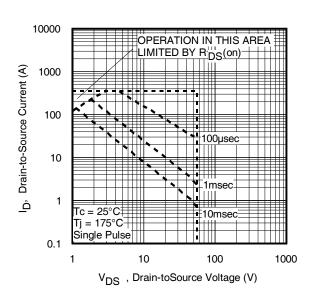
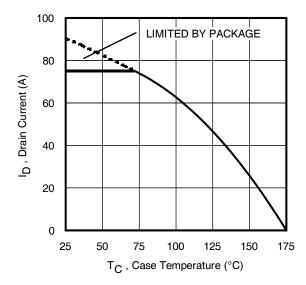


Fig 8. Maximum Safe Operating Area

4





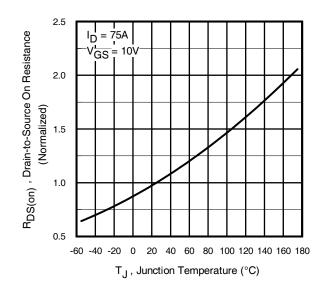


Fig 9. Maximum Drain Current vs. Case Temperature

Fig 10. Normalized On-Resistance vs. Temperature

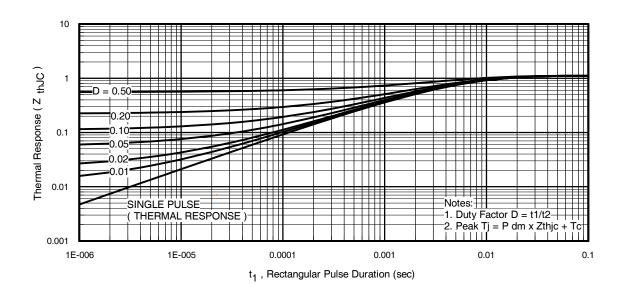


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



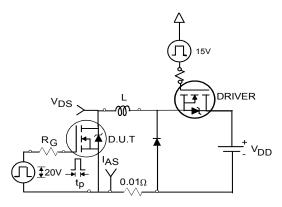


Fig 12a. Unclamped Inductive Test Circuit

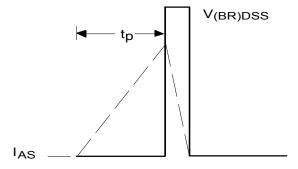


Fig 12b. Unclamped Inductive Waveforms

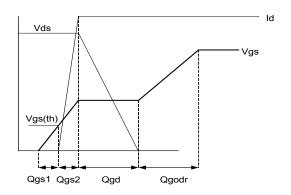


Fig 13a. Gate Charge Waveform

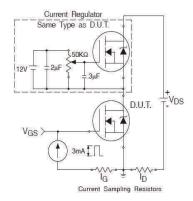


Fig 13b. Gate Charge Test Circuit

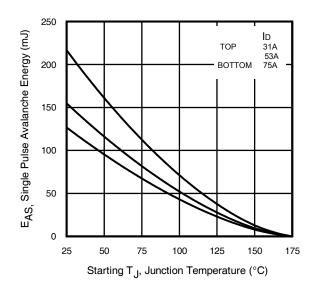


Fig 12c. Maximum Avalanche Energy vs. Drain Current

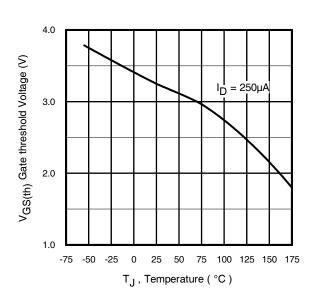


Fig 14. Threshold Voltage vs. Temperature



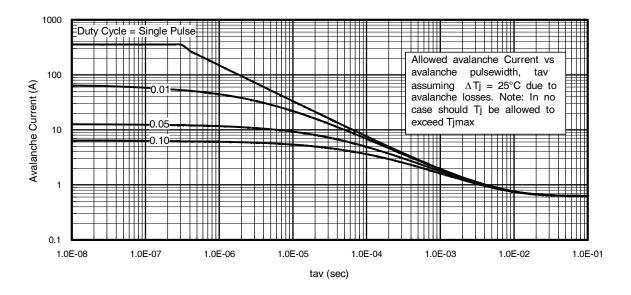


Fig 15. Typical Avalanche Current vs. Pulse width

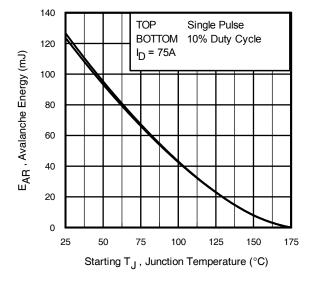


Fig 16. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 15, 16: (For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption:

 Durally a thermal phanemana and failure.
 - Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. lav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$



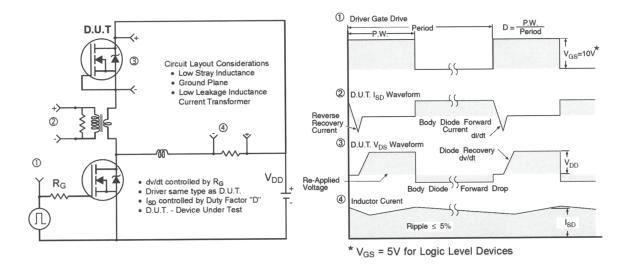


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

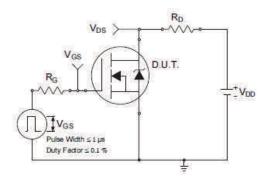


Fig 18a. Switching Time Test Circuit

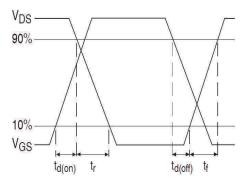
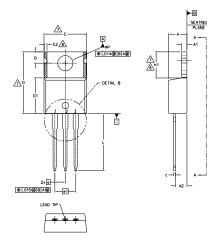
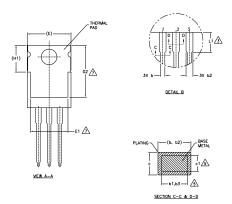


Fig 18b. Switching Time Waveforms



TO-220AB Package Outline (Dimensions are shown in millimeters (inches))





NOTES:

- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994.

- DIMENSIONING AND TOLERANGING AS PER ASME 114.5 M = 1994.

 DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].

 LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.

 DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH

 SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

DIMENSION 61, 63 & c1 APPLY TO BASE METAL ONLY.

- CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1
- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED.
- OUTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (max.) AND D2 (min.) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE.

| SYMBOL | MILLIM | ETERS | INC | | |
|--------|--------|-------|------|------|-------|
| | MIN. | MAX. | MIN. | MAX. | NOTES |
| A | 3.56 | 4.83 | .140 | .190 | |
| A1 | 1.14 | 1.40 | .045 | .055 | |
| A2 | 2.03 | 2.92 | .080 | .115 | |
| b | 0.38 | 1.01 | .015 | .040 | |
| b1 | 0.38 | 0.97 | .015 | .038 | 5 |
| b2 | 1,14 | 1.78 | .045 | .070 | |
| b3 | 1.14 | 1.73 | .045 | .068 | 5 |
| c | 0.36 | 0.61 | .014 | .024 | |
| c1 | 0.36 | 0.56 | .014 | .022 | 5 |
| D | 14.22 | 16.51 | .560 | .650 | 4 |
| D1 | 8.38 | 9.02 | .330 | .355 | |
| D2 | 11.68 | 12.88 | .460 | .507 | 7 |
| E | 9.65 | 10.67 | .380 | .420 | 4,7 |
| E1 | 6.86 | 8.89 | .270 | .350 | 7 |
| E2 | - | 0.76 | _ | .030 | 8 |
| e | 2.54 | BSC | .100 | BSC | |
| e1 | 5.08 | BSC | .200 | BSC | |
| H1 | 5.84 | 6.86 | .230 | .270 | 7,8 |
| L | 12.70 | 14.73 | .500 | .580 | |
| L1 | 3.56 | 4.06 | .140 | .160 | 3 |
| ØΡ | 3.54 | 4.08 | .139 | .161 | |
| Q | 2.54 | 3.42 | .100 | .135 | |

LEAD ASSIGNMENTS

HEXFET

- 1.- GATE 2.- DRAIN 3.- SOURCE

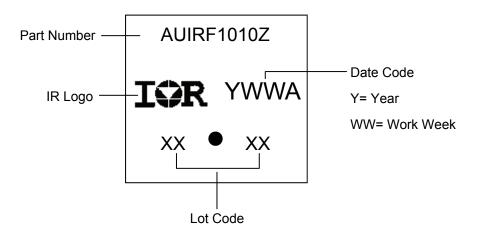
IGBTs, CoPACK

1.- GATE 2.- COLLECTOR 3.- EMITTER

DIODES

- 1.- ANODE 2.- CATHODE 3.- ANODE

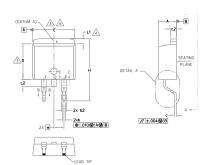
TO-220AB Part Marking Information

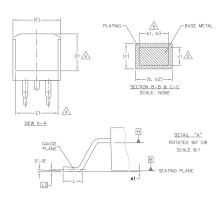


TO-220AB package is not recommended for Surface Mount Application.



D²Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

| S | | | N | | | |
|--------|--------|-------|------|--------|------------------|--|
| M B | MILLIM | ETERS | INC | INCHES | | |
| 0 L | MIN. | MAX. | MIN. | MAX. | O T E S | |
| А | 4.06 | 4.83 | .160 | .190 | | |
| A1 | 0.00 | 0.254 | .000 | .010 | | |
| Ь | 0.51 | 0.99 | .020 | .039 | | |
| ь1 | 0.51 | 0.89 | .020 | .035 | 5 | |
| b2 | 1.14 | 1.78 | .045 | .070 | | |
| ь3 | 1.14 | 1.73 | .045 | .068 | 5 | |
| С | 0.38 | 0.74 | .015 | .029 | | |
| c1 | 0.38 | 0.58 | .015 | .023 | 5 | |
| c2 | 1.14 | 1.65 | .045 | .065 | | |
| D | 8.38 | 9.65 | .330 | .380 | 3 | |
| D1 | 6.86 | _ | .270 | _ | 4 | |
| E | 9.65 | 10.67 | .380 | .420 | 3,4 | |
| E1 | 6.22 | _ | .245 | _ | 4 | |
| е | 2.54 | BSC | .100 | BSC | | |
| Н | 14.61 | 15.88 | .575 | .625 | | |
| L | 1.78 | 2.79 | .070 | .110 | | |
| L1 | _ | 1.68 | _ | .066 | 4 | |
| L2 | _ | 1.78 | _ | .070 | | |
| L3 | 0.25 | BSC | .010 | BSC | | |

LEAD ASSIGNMENTS

DIODES

1.- ANODE (TWO DIE) / OPEN (ONE DIE)
2, 4.- CATHODE
3.- ANODE

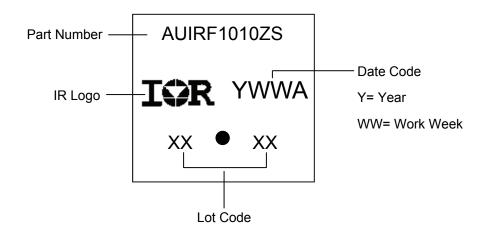
HEXFET

IGBTs, CoPACK

1.- GATE 2, 4.- DRAIN 3.- SOURCE

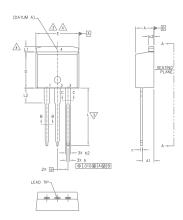
2, 4.- COLLECTOR 3.- EMITTER

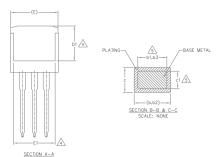
D²Pak (TO-263AB) Part Marking Information





TO-262 Package Outline (Dimensions are shown in millimeters (inches)





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3\DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

6. CONTROLLING DIMENSION: INCH.

7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

LEAD ASSIGNMENTS

IGBTs, CoPACK

- 1.- GATE 2.- COLLECTOR 3.- EMITTER 4.- COLLECTOR

HEXFET

DIODES

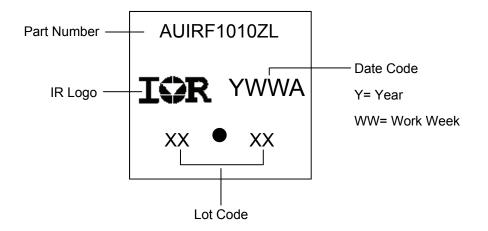
1.- ANODE (TWO DIE) / OPEN (ONE DIE)
2, 4.- CATHODE
3.- ANODE 1.- GATE

DRAIN

| 5. — | SOURCE | ٥. – | AN |
|------|--------|------|----|
| 4.— | DRAIN | | |
| | | | |

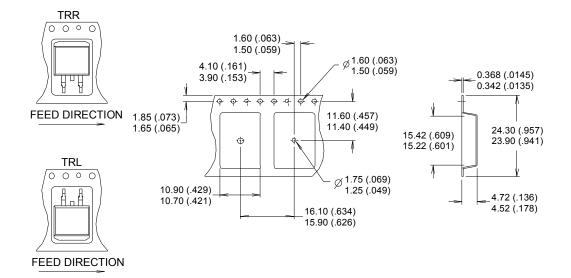
| S | | | | | | |
|----|--------|-------|--------|--------|-----------|--|
| M | | DIMEN | ISIONS | | N | |
| B | MILLIM | ETERS | INC | INCHES | | |
| L | MIN. | MAX. | MIN. | MAX. | N O T E S | |
| Α | 4.06 | 4.83 | .160 | .190 | | |
| A1 | 2.03 | 3.02 | .080 | .119 | | |
| b | 0.51 | 0.99 | .020 | .039 | | |
| ь1 | 0.51 | 0.89 | .020 | .035 | 5 | |
| b2 | 1.14 | 1.78 | .045 | .070 | | |
| ь3 | 1.14 | 1.73 | .045 | .068 | 5 | |
| С | 0.38 | 0.74 | .015 | .029 | | |
| с1 | 0.38 | 0.58 | .015 | .023 | 5 | |
| c2 | 1.14 | 1.65 | .045 | .065 | | |
| D | 8.38 | 9.65 | .330 | .380 | 3 | |
| D1 | 6.86 | - | .270 | _ | 4 | |
| Ε | 9.65 | 10.67 | .380 | .420 | 3,4 | |
| E1 | 6.22 | _ | .245 | | 4 | |
| е | 2.54 | BSC | .100 | BSC | | |
| L | 13.46 | 14.10 | .530 | .555 | | |
| L1 | _ | 1.65 | _ | .065 | 4 | |
| L2 | 3.56 | 3.71 | .140 | .146 | | |

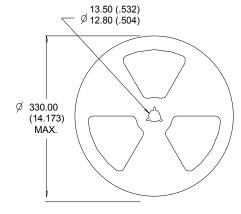
TO-262 Part Marking Information





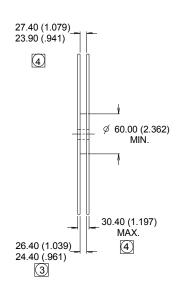
D²Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))







- COMFORMS TO EIA-418.
- CONTROLLING DIMENSION: MILLIMETER.
- 3
- DIMENSION MEASURED @ HUB.
 INCLUDES FLANGE DISTORTION @ OUTER EDGE.





Qualification Information

| | | Automotive (per AEC-Q101) | | | |
|----------------------------|---|---|--|--|--|
| | | (per ALC-Q101) | | | |
| | | Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level. | | | |
| Moisture Sensitivity Level | | N/A | | | |
| | | MSL1 | | | |
| | | MSLI | | | |
| Machina Madal | Class M4 (+/- 700V) [†] | | | | |
| Macrille Model | AEC-Q101-002 | | | | |
| Human Bady Madal | Class H1C (+/-1500V) [†] | | | | |
| numan Body Wodei | AEC-Q101-001 | | | | |
| Charged Davise Medal | Class C5 (+/-2000V) [†] | | | | |
| Charged Device Model | | AEC-Q101-005 | | | |
| RoHS Compliant | | Yes | | | |
| | Machine Model Human Body Model Charged Device Model | Sensitivity Level TO-220AB TO-262 D²-Pak Machine Model Human Body Model Charged Device Model | | | |

[†] Highest passing voltage.

Revision History

| Date | Comments |
|------------|--|
| 11/6//2015 | Updated datasheet with corporate template Corrected ordering table on page 1. |
| 9/18/2017 | Corrected typo error on part marking on page 9,10,11. |

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